


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588608	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANISHI ET AL.
	<b>Examiner</b>  Christian LaForgia	<b>Art Unit</b>  2139

SEARCHED			
Class	Subclass	Date	Examiner
726	36	2/29/08	clf

SEARCH NOTES		
Search Notes	Date	Examiner
East search - see enclosed printout	2/29/08	clf
IEEE search	2/29/08	clf
ACM search	2/29/08	clf
Google search	2/29/08	clf
Inventor search	2/28/09	clf
assignee search	2/28/09	clf

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner